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"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "<u>Embedded -</u> <u>Microcontrollers</u>"

Details

Product Status	Active
Core Processor	PIC
Core Size	8-Bit
Speed	32MHz
Connectivity	I ² C, LINbus, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, POR, PWM, WDT
Number of I/O	25
Program Memory Size	28KB (16K x 14)
Program Memory Type	FLASH
EEPROM Size	224 x 8
RAM Size	2K x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 3.6V
Data Converters	A/D 24x10b; D/A 1x5b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	28-SSOP (0.209", 5.30mm Width)
Supplier Device Package	28-SSOP
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/pic16lf15356t-i-ss

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

IABLE 4	4-11: SPECI	AL FUNCTION	REGISTER	SUMMARY	BANKS 0-	63 (CONTIN	IUED)				
Address	Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Value on: POR, BOR	V <u>alue o</u> n: MCLR
Bank 12											
	CPU CORE REGISTERS; see Table 4-3 for specifics										
60Ch	CWG1CLKCON	—	_	—	_	—	—	_	CS	0	0
60Dh	CWG1DAT	_	_	_	_		DA	T<3:0>		0000	0000
60Eh	CWG1DBR	_	—			DB	R<5:0>			00 0000	00 0000
60Fh	CWG1DBF	_	—			DB	F<5:0>			00 0000	00 0000
610h	CWG1CON0	EN	LD	—	—	—		MODE<2:0>	•	00000	00000
611h	CWG1CON1	_	—	IN	—	POLD	POLC	POLB	POLA	x- 0000	u- 0000
612h	CWG1AS0	SHUTDOWN	REN	LSBD	<2:0>	LSAC	<2:0>	—	_	0001 01	0001 01
613h	CWG1AS1	_	—	_	AS4E	AS3E AS2E AS1E AS0E				0 0000	u 0000
614h	CWG1STR	OVRD	OVRC	OVRB OVRA STRD STRC STRB STRA 0000 0000 0000							0000 0000
615h											
 61Fh	_				Unimpler	nenteu				_	

TABLE 4-11: SPECIAL FUNCTION REGISTER SUMMARY BANKS 0-63 (CONTINUED)

Legend: x = unknown, u = unchanged, q = depends on condition, - = unimplemented, read as '0', x = reserved. Shaded locations unimplemented, read as '0'.

PIC16(L)F15356/75/76/85/86

6.1 Microchip Unique identifier (MUI)

The PIC16(L)F15356/75/76/85/86 devices are individually encoded during final manufacturing with a Microchip Unique Identifier, or MUI. The MUI cannot be erased by a Bulk Erase command or any other useraccessible means. This feature allows for manufacturing traceability of Microchip Technology devices in applications where this is a required. It may also be used by the application manufacturer for a number of functions that require unverified unique identification, such as:

- · Tracking the device
- Unique serial number

The MUI consists of nine program words. When taken together, these fields form a unique identifier. The MUI is stored in nine read-only locations, located between 8100h to 8109h in the DIA space. Table 6-1 lists the addresses of the identifier words.

Note:	For applications that require verified unique
	identification, contact your Microchip Tech-
	nology sales office to create a Serialized
	Quick Turn Programming option.

6.2 External Unique Identifier (EUI)

The EUI data is stored at locations 810Ah to 8111h in the program memory region. This region is an optional space for placing application specific information. The data is coded per customer requirements during manufacturing. The EUI cannot be erased by a Bulk Erase command.

Note: Data is stored in this address range on receiving a request from the customer. The customer may contact the local sales representative or Field Applications Engineer, and provide them the unique identifier information that is required to be stored in this region.

6.3 Analog-to-Digital Conversion Data of the Temperature Sensor

The purpose of the temperature indicator module is to provide a temperature-dependent voltage that can be measured by an analog module. **Section 19.0 "Temperature Indicator Module**" explains the operation of the Temperature Indicator module and defines terms such as the low range and high range settings of the sensor.

The DIA table contains the internal ADC measurement values of the temperature sensor for low and high range at fixed points of reference. The values are measured during test and are unique to each device. The right-justified ADC readings are stored in the DIA memory region. The calibration data can be used to plot the approximate sensor output voltage, VTSENSE vs. Temperature curve.

- **TSLR<3:1>**: Address 8112h to 8114h store the measurements for the low range setting of the temperature sensor at VDD = 3V.
- TSHR<3:1>: Address 8115h to 8117h store the measurements for the high range setting of the temperature sensor at VDD = 3V.

The stored measurements are made by the device ADC using the internal VREF = 2.048V.

6.4 Fixed Voltage Reference Data

The Fixed Voltage Reference, or FVR, is a stable voltage reference, independent of VDD, with 1.024V, 2.048V or 4.096V selectable output levels. The output of the FVR can be configured to supply a reference voltage to the following:

- ADC input channel
- ADC positive reference
- Comparator positive input
- Digital-to-Analog Converter

For more information on the FVR, refer to **Section 18.0 "Fixed Voltage Reference (FVR)"**.

The DIA stores measured FVR voltages for this device in mV for the different buffer settings of 1x, 2x or 4x at program memory locations 8118h to 811Dh.

- FVRA1X stores the value of ADC FVR1 Output voltage for 1x setting (in mV)
- FVRA2X stores the value of ADC FVR1 Output Voltage for 2x setting (in mV)
- FVRA4X stores the value of ADC FVR1 Output Voltage for 4x setting (in mV)
- FVRC1X stores the value of Comparator FVR2 output voltage for 1x setting (in mV)
- FVRC2X stores the value of Comparator FVR2 output voltage for 2x setting (in mV)
- FVRC4X stores the value of Comparator FVR2 output voltage for 4x setting (in mV)

8.1 Power-on Reset (POR)

The POR circuit holds the device in Reset until VDD has reached an acceptable level for minimum operation. Slow rising VDD, fast operating speeds or analog performance may require greater than minimum VDD. The PWRT, BOR or MCLR features can be used to extend the start-up period until all device operation conditions have been met.

8.2 Brown-out Reset (BOR)

The BOR circuit holds the device in Reset when VDD reaches a selectable minimum level. Between the POR and BOR, complete voltage range coverage for execution protection can be implemented.

The Brown-out Reset module has four operating modes controlled by the BOREN<1:0> bits in Configuration Words. The four operating modes are:

- · BOR is always on
- · BOR is off when in Sleep
- BOR is controlled by software
- BOR is always off

Refer to Table 8-1 for more information.

The Brown-out Reset voltage level is selectable by configuring the BORV bit in Configuration Words.

A VDD noise rejection filter prevents the BOR from triggering on small events. If VDD falls below VBOR for a duration greater than parameter TBORDC, the device will reset. See Figure 8-2 for more information.

BOREN<1:0>	SBOREN	Device Mode	BOR Mode	Instruction Execution upon: Release of POR or Wake-up from Sleep						
11	Х	Х	Active	Wait for release of BOR ⁽¹⁾ (BORRDY = 1)						
1.0	37	Awake	Active	Waits for release of BOR (BORRDY = 1)						
10	Х	Sleep	Disabled	Waits for BOR Reset release						
0.1	1	x	Active	Waits for BOR Reset release (BORRDY = 1)						
01	0	х	Disabled	Paging immediately (POPPDY =)						
00	Х	Х	Disabled	Begins immediately (BORRDY = x)						

TABLE 8-1: BOR OPERATING MODES

Note 1: In this specific case, "Release of POR" and "Wake-up from Sleep", there is no delay in start-up. The BOR ready flag, (BORRDY = 1), will be set before the CPU is ready to execute instructions because the BOR circuit is forced on by the BOREN<1:0> bits.

8.2.1 BOR IS ALWAYS ON

When the BOREN bits of Configuration Words are programmed to '11', the BOR is always on. The device start-up will be delayed until the BOR is ready and VDD is higher than the BOR threshold.

BOR protection is active during Sleep. The BOR does not delay wake-up from Sleep.

8.2.2 BOR IS OFF IN SLEEP

When the BOREN bits of Configuration Words are programmed to '10', the BOR is on, except in Sleep. The device start-up will be delayed until the BOR is ready and VDD is higher than the BOR threshold.

BOR protection is not active during Sleep. The device wake-up will be delayed until the BOR is ready.

8.4 Low-Power Brown-out Reset (LPBOR)

The Low-Power Brown-out Reset (LPBOR) is an important part of the Reset subsystem. Refer to Figure 8-1 to see how the BOR and LPBOR interact with other modules.

The LPBOR is used to monitor the external VDD pin. When too low of a voltage is detected, the device is held in Reset.

8.4.1 ENABLING LPBOR

The LPBOR is controlled by the \overrightarrow{LPBOR} bit of the Configuration Word (Register 5-1). When the device is erased, the LPBOR module defaults to disabled.

8.4.2 LPBOR MODULE OUTPUT

The output of the LPBOR module is a signal indicating whether or not a Reset is to be asserted. When this occurs, a register bit (BOR) is changed to indicate that a BOR Reset has occurred. The same bit is set for either the BOR or the LPBOR (refer to Register 8-3). This signal is OR'd with the output of the BOR module to provide the generic BOR signal, which goes to the PCON register and to the power control block. Refer to Figure 8-1 for the OR gate connections of the BOR and LPBOR Reset signals, which eventually generates one common BOR Reset.

8.5 MCLR

The $\overline{\text{MCLR}}$ is an optional external input that can reset the device. The $\overline{\text{MCLR}}$ function is controlled by the MCLRE bit of Configuration Words and the LVP bit of Configuration Words (Table 8-2).

 TABLE 8-2:
 MCLR CONFIGURATION

MCLRE	LVP	MCLR
0	0	Disabled
1	0	Enabled
x	1	Enabled

8.5.1 MCLR ENABLED

When MCLR is enabled and the pin is held low, the device is held in Reset. The MCLR pin is connected to VDD through an internal weak pull-up. Refer to **Section 2.3 "Master Clear (MCLR) Pin"** for recommended MCLR connections.

The device has a noise filter in the $\overline{\text{MCLR}}$ Reset path. The filter will detect and ignore small pulses.

Note: A Reset does not drive the MCLR pin low.

8.5.2 MCLR DISABLED

When MCLR is disabled, the pin functions as a general purpose input and the internal weak pull-up is under software control. See **Section 14.1 "I/O Priorities"** for more information.

8.6 Windowed Watchdog Timer (WWDT) Reset

The Watchdog Timer generates a Reset if the firmware does not issue a CLRWDT instruction within the time-out period and the window is open. The TO and PD bits in the STATUS register and the WDT bit in PCON are changed to indicate a WDT Reset caused by the timer overflowing, and WDTWV bit in the PCON register is changed to indicate a WDT Reset caused by a window violation. See **Section 12.0 "Windowed Watchdog Timer (WWDT)"** for more information.

8.7 RESET Instruction

A RESET instruction will cause a device Reset. The \overline{RI} bit in the PCON register will be set to '0'. See Table 8-4 for default conditions after a RESET instruction has occurred.

8.8 Stack Overflow/Underflow Reset

The device can reset when the Stack Overflows or Underflows. The STKOVF or STKUNF bits of the PCON register indicate the Reset condition. These Resets are enabled by setting the STVREN bit in Configuration Words. See **Section 4.5.2** "**Overflow/Underflow Reset**" for more information.

8.9 Programming Mode Exit

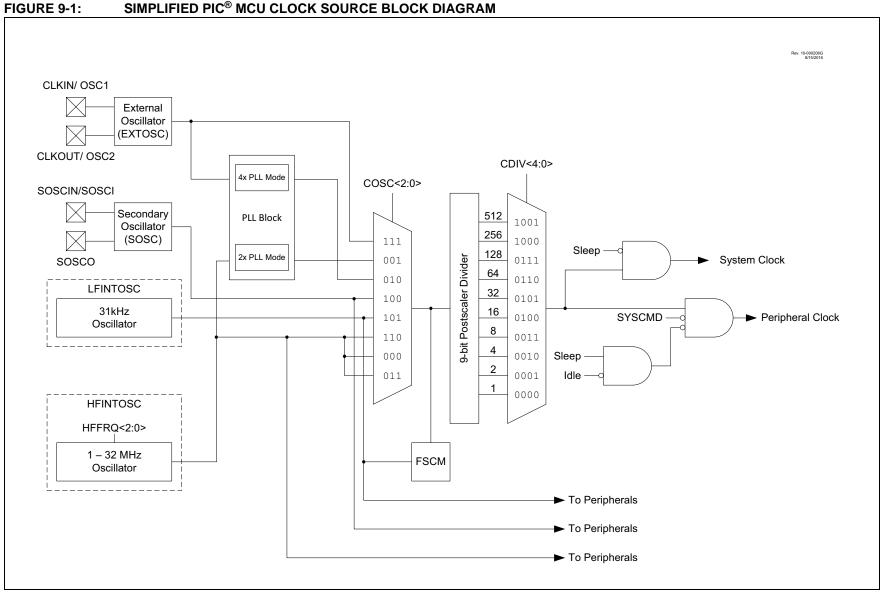
Upon exit of In-Circuit Serial Programming[™] (ICSP[™]) mode, the device will behave as if a POR had just occurred (the device does not reset upon run time self-programming/erase operations).

8.10 Power-up Timer

The Power-up Timer optionally delays device execution after a BOR or POR event. This timer is typically used to allow VDD to stabilize before allowing the device to start running.

The Power-up Timer is controlled by the $\overrightarrow{\mathsf{PWRTE}}$ bit of the Configuration Words.

The Power-up Timer provides a nominal 64 ms time out on POR or Brown-out Reset. The device is held in Reset as long as PWRT is active. The PWRT delay allows additional time for the VDD to rise to an acceptable level. The Power-up Timer is enabled by clearing the PWRTE bit in the Configuration Words. The Power-up Timer starts after the release of the POR and BOR. For additional information, refer to Application Note AN607, "*Power-up Trouble Shooting*" (DS00607).



PIC16(L)F15356/75/76/85/86

SIMPLIFIED PIC® MCU CLOCK SOURCE BLOCK DIAGRAM

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Preliminary

10.0 INTERRUPTS

The interrupt feature allows certain events to preempt normal program flow. Firmware is used to determine the source of the interrupt and act accordingly. Some interrupts can be configured to wake the MCU from Sleep mode.

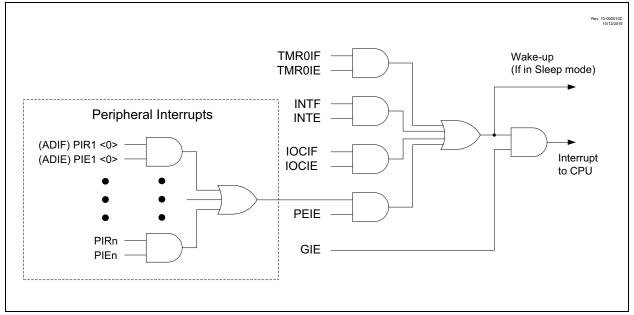
This chapter contains the following information for Interrupts:

- Operation
- Interrupt Latency
- Interrupts During Sleep
- INT Pin
- · Automatic Context Saving

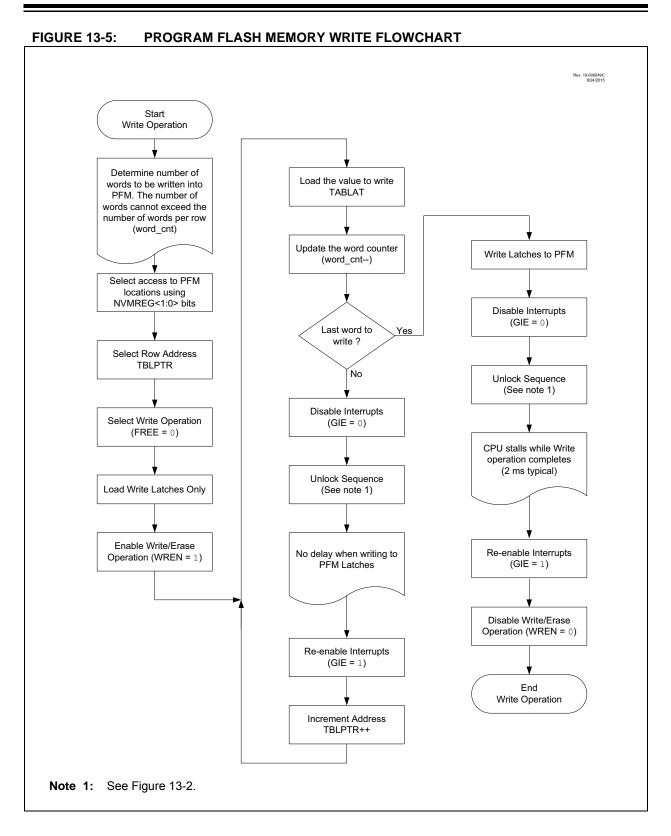
Many peripherals produce interrupts. Refer to the corresponding chapters for details.

A block diagram of the interrupt logic is shown in Figure 10-1.

FIGURE 10-1: INTERRUPT LOGIC



PIC16(L)F15356/75/76/85/86



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| R/W-1/1 |
|---------|---------|---------|---------|---------|---------|---------|---------|
| ANSD7 | ANSD6 | ANSD5 | ANSD4 | ANSD3 | ANSD2 | ANSD1 | ANSD0 |
| bit 7 | | | | | | | bit 0 |

Legend:		
R = Readable bit	W = Writable bit	U = Unimplemented bit, read as '0'
u = Bit is unchanged	x = Bit is unknown	-n/n = Value at POR and BOR/Value at all other Resets
'1' = Bit is set	'0' = Bit is cleared	

bit 7-0 **ANSD<7:0>**: Analog Select between Analog or Digital Function on Pins RD<7:0>, respectively⁽¹⁾ 0 = Digital I/O. Pin is assigned to port or digital special function. 1 = Analog input. Pin is assigned as analog input⁽¹⁾. Digital input buffer disabled.

REGISTER 14-29: WPUD: WEAK PULL-UP PORTD REGISTER

| R/W-0/0 |
|---------|---------|---------|---------|---------|---------|---------|---------|
| WPUD7 | WPUD6 | WPUD5 | WPUD4 | WPUD3 | WPUD2 | WPUD1 | WPUD0 |
| bit 7 | | | | | | | bit 0 |

Legend:		
R = Readable bit	W = Writable bit	U = Unimplemented bit, read as '0'
u = Bit is unchanged	x = Bit is unknown	-n/n = Value at POR and BOR/Value at all other Resets
'1' = Bit is set	'0' = Bit is cleared	

bit 7-0 WPUD<7:0>: Weak Pull-up Register bits⁽¹⁾

1 = Pull-up enabled

0 = Pull-up disabled

Note 1: The weak pull-up device is automatically disabled if the pin is configured as an output.

Note 1: When setting a pin to an analog input, the corresponding TRIS bit must be set to Input mode in order to allow external control of the voltage on the pin.

21.0 5-BIT DIGITAL-TO-ANALOG CONVERTER (DAC1) MODULE

The Digital-to-Analog Converter supplies a variable voltage reference, ratiometric with the input source, with 32 selectable output levels.

The input of the DAC can be connected to:

- External VREF pins
- VDD supply voltage
- FVR (Fixed Voltage Reference)

The output of the DAC can be configured to supply a reference voltage to the following:

- Comparator positive input
- ADC input channel
- DAC1OUT pin

The Digital-to-Analog Converter (DAC) is enabled by setting the DAC1EN bit of the DAC1CON0 register.

EQUATION 21-1: DAC OUTPUT VOLTAGE

21.1 Output Voltage Selection

The DAC has 32 voltage level ranges. The 32 levels are set with the DAC1R<4:0> bits of the DAC1CON1 register.

The DAC output voltage is determined by Equation 21-1:

 $V_{OUT} = \left(V_{SOURCE+} - V_{SOURCE-} \times \frac{DAC1R\langle 4:0 \rangle}{2^5} \right) + (V_{SOURCE-})$ $V_{SOURCE+} = V_{DD} \quad or \quad V_{REF+} \quad or \; FVR$ $V_{SOURCE-} = V_{SS} \quad or \; V_{REF-}$

21.2 Ratiometric Output Level

The DAC output value is derived using a resistor ladder with each end of the ladder tied to a positive and negative voltage reference input source. If the voltage of either input source fluctuates, a similar fluctuation will result in the DAC output value.

The value of the individual resistors within the ladder can be found in Table 37-15.

21.3 DAC Voltage Reference Output

The DAC voltage can be output to the DAC1OUT1/2 pins by setting the DAC1OE1/2 bits of the DAC1CON0 register, respectively. Selecting the DAC reference voltage for output on the DAC1OUT1/2 pins automatically overrides the digital output buffer and digital input threshold detector functions, disables the weak pull-up, and disables the current-controlled drive function of that pin. Reading the DAC1OUT1/2 pin when it has been configured for DAC reference voltage output will always return a '0'.

Due to the limited current drive capability, a buffer must be used on the DAC voltage reference output for external connections to the DAC1OUT1/2 pins. Figure 21-2 shows an example buffering technique.

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27.0 TIMER2 MODULE WITH HARDWARE LIMIT TIMER (HLT)

The Timer2 modules are 8-bit timers that can operate as free-running period counters or in conjunction with external signals that control start, run, freeze, and reset operation in One-Shot and Monostable modes of operation. Sophisticated waveform control such as pulse density modulation are possible by combining the operation of these timers with other internal peripherals such as the comparators and CCP modules. Features of the timer include:

- 8-bit timer register
- 8-bit period register

- · Selectable external hardware timer Resets
- Programmable prescaler (1:1 to 1:128)
- Programmable postscaler (1:1 to 1:16)
- · Selectable synchronous/asynchronous operation
- Alternate clock sources
- Interrupt-on-period
- · Three modes of operation:
 - Free Running Period
 - One-shot
 - Monostable

See Figure 27-1 for a block diagram of Timer2. See Figure 27-2 for the clock source block diagram.

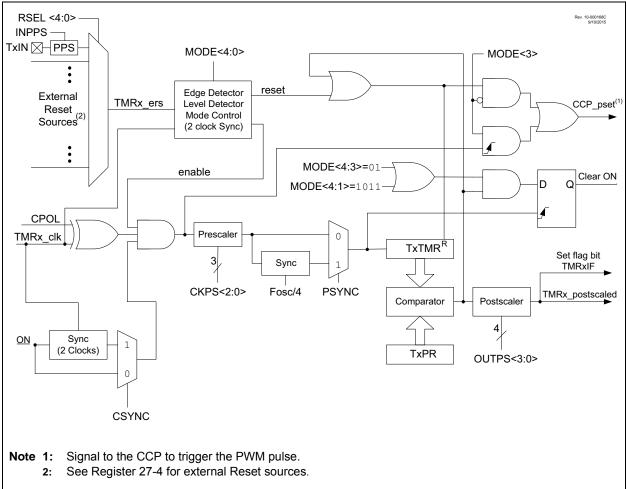
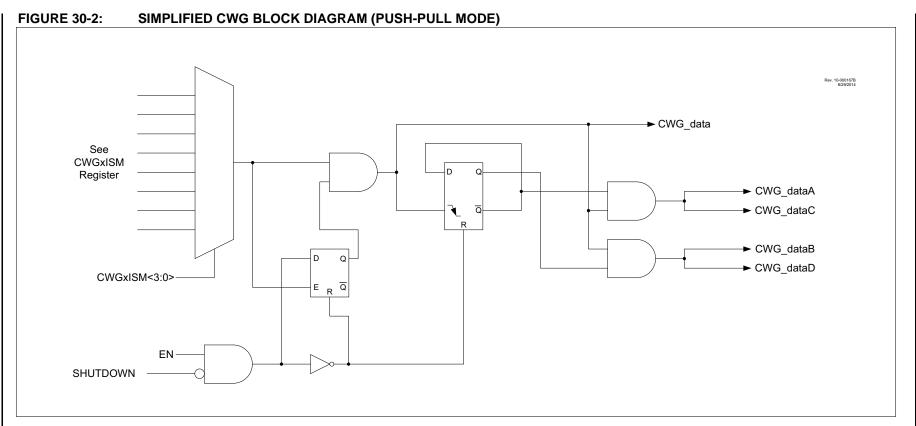


FIGURE 27-1: TIMER2 BLOCK DIAGRAM



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30.10 Auto-Shutdown

Auto-shutdown is a method to immediately override the CWG output levels with specific overrides that allow for safe shutdown of the circuit. The shutdown state can be either cleared automatically or held until cleared by software. The auto-shutdown circuit is illustrated in Figure 30-12.

30.10.1 SHUTDOWN

The shutdown state can be entered by either of the following two methods:

- Software generated
- External Input

30.10.1.1 Software Generated Shutdown

Setting the SHUTDOWN bit of the CWG1AS0 register will force the CWG into the shutdown state.

When the auto-restart is disabled, the shutdown state will persist as long as the SHUTDOWN bit is set.

When auto-restart is enabled, the SHUTDOWN bit will clear automatically and resume operation on the next rising edge event.

30.10.2 EXTERNAL INPUT SOURCE

External shutdown inputs provide the fastest way to safely suspend CWG operation in the event of a Fault condition. When any of the selected shutdown inputs goes active, the CWG outputs will immediately go to the selected override levels without software delay. Several input sources can be selected to cause a shutdown condition. All input sources are active-low. The sources are:

- Comparator C1OUT_sync
- Comparator C2OUT_sync
- · Timer2 TMR2_postscaled
- CWG1IN input pin

Shutdown inputs are selected using the CWG1AS1 register (Register 30-6).

Note: Shutdown inputs are level sensitive, not edge sensitive. The shutdown state cannot be cleared, except by disabling auto-shutdown, as long as the shutdown input level persists.

30.11 Operation During Sleep

The CWG module operates independently from the system clock and will continue to run during Sleep, provided that the clock and input sources selected remain active.

The HFINTOSC remains active during Sleep when all the following conditions are met:

- CWG module is enabled
- · Input source is active
- HFINTOSC is selected as the clock source, regardless of the system clock source selected.

In other words, if the HFINTOSC is simultaneously selected as the system clock and the CWG clock source, when the CWG is enabled and the input source is active, then the CPU will go idle during Sleep, but the HFINTOSC will remain active and the CWG will continue to operate. This will have a direct effect on the Sleep mode current.

TABLE 31-4:	SUMMARY OF REGISTERS ASSOCIATED WITH CLCx (continued)
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Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0		
CLC4GLS1	—		LC4G2D3T	LC4G2D3N	LC4G2D2T	LC4G2D2N	LC4G2D1T	LC4G2D1N	414	
CLC4GLS2	—		LC4G3D3T	LC4G3D3N	LC4G3D2T	LC4G3D2N	LC4G3D1T	LC4G3D1N	415	
CLC4GLS3	_	_	LC4G4D3T	LC4G4D3N	LC4G4D2T	LC4G4D2N	LC4G4D1T	LC4G4D1N	416	
CLCIN0PPS	_	_		CLCIN0PPS<5:0>						
CLCIN1PPS	_	_		CLCIN1PPS<5:0>						
CLCIN2PPS	_	_		CLCIN2PPS<5:0>						
CLCIN3PPS	_	_			CLCIN3	PPS<5:0>			241	

Legend: — = unimplemented, read as '0'. Shaded cells are unused by the CLCx modules.

	REGISTER 32-4:	SSPxCON3: SSPx CONTROL REGISTER 3
--	----------------	-----------------------------------

R-0/0	R/W-0/0	R/W-0/0	R/W-0/0	R/W-0/0	R/W-0/0	R/W-0/0	R/W-0/0
ACKTIM	³⁾ PCIE	SCIE	BOEN	SDAHT	SBCDE	AHEN	DHEN
bit 7	<u>.</u>				•		bit
Legend:							
R = Readab	ole bit	W = Writable b	bit	U = Unimplem	ented bit, read as	ʻ0'	
u = Bit is ur	changed	x = Bit is unkn	own	-n/n = Value at	POR and BOR/V	alue at all other l	Resets
'1' = Bit is s	et	'0' = Bit is clea	red				
			0	(2)			
bit 7		nowledge Time S			oth curr		
		the I ² C bus is in a knowledge seque			on 8 th falling edge of SCL clock	of SCL clock	
bit 6		ondition Interrupt					
		errupt on detection					
		ction interrupts ar					
bit 5		ondition Interrupt	•	• ·			
		errupt on detection ction interrupts ar		start conditions			
oit 4		Overwrite Enabl					
511 4	In SPI Slave n						
					shifted in ignoring		
		•			egister already se	et, SSPOV bit of	the SSPxCON
	· · ·	ster is set, and the mode and SPI M	•	dated			
	In I ² C Slave m						
				nerated for a rec	eived address/da	ita byte, ignoring	the state of th
		OV bit only if the xBUF is only upda)V is clear			
oit 3		Hold Time Selec					
		of 300 ns hold tin	•	• ·	of SCL		
		of 100 ns hold tin					
oit 2	SBCDE: Slave	e Mode Bus Colli	sion Detect Ena	ble bit (I ² C Slave	e mode only)		
		g edge of SCL, SI is set, and bus go		w when the moo	lule is outputting a	a high state, the E	3CL1IF bit of th
		ave bus collision i collision i	•				
oit 1	AHEN: Addres	ss Hold Enable b	it (I ² C Slave mo	de only)			
		the eighth falling will be cleared an			eceived address	byte; CKP bit of	the SSPxCON
		olding is disabled					
bit 0		Hold Enable bit (I			4a budau alawa 1		
		N1 register and S		or a received da	ta byte; slave ha	rdware clears the	e CKP bit of tr
Note 1:	For daisy-chained S	SPI operation; allo	ws the user to ic	nore all but the	ast received byte	. SSPOV is still s	et when a new
	byte is received and						
2:	This bit has no effect	ct in Slave modes	s that Start and S	Stop condition de	tection is explicit	y listed as enable	ed.

- 2: This bit has no effect in Slave modes that Start and Stop condition detection is explicitly listed as enabled.
- 3: The ACKTIM Status bit is only active when the AHEN bit or DHEN bit is set.

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REGISTER 33-7: SPxBRGH^(1, 2): BAUD RATE GENERATOR HIGH REGISTER

R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0	R/W-0			
SPxBRG<15:8>										
bit 7							bit 0			
Legend:										

R = Readable bit	W = Writable bit	U = Unimplemented bit, read as '0'
u = Bit is unchanged	x = Bit is unknown	-n/n = Value at POR and BOR/Value at all other Resets
'1' = Bit is set	'0' = Bit is cleared	

bit 7 SPxBRG<15:8>: Upper eight bits of the Baud Rate Generator

Note 1: SPxBRGH value is ignored for all modes unless BAUDxCON<BRG16> is active.

2: Writing to SPxBRGH resets the BRG counter.

Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Register on Page		
INTCON	GIE	PEIE	-	_	_	—	_	INTEDG	146		
PIR3	RC2IF	TX2IF	RC1IF	TX1IF	BCL2IF	SSP2IF	BCL1IF	SSP1IF	158		
PIE3	RC2IE	TX2IE	RC1IE	TX1IE	BCL2IE	SSP2IE	BCL1IE	SSP1IE	150		
RCxSTA	SPEN	RX9	SREN	CREN	ADDEN	FERR	OERR	RX9D	491		
TXxSTA	CSRC	TX9	TXEN	SYNC	SENDB	BRGH	TRMT	TX9D	490		
BAUDxCON	ABDOVF	RCIDL	_	SCKP	BRG16	—	WUE	ABDEN	492		
RCxREG	EUSART Rec	eive Data Regis	ter						493*		
TXxREG	EUSART Trar	nsmit Data Reg	lister						493*		
SPxBRGL				SPxBR	G<7:0>				493*		
SPxBRGH				SPxBR	G<15:8>				494*		
RXPPS	_	—			RXPP	S<5:0>			241		
CKPPS	_	_		CXPPS<5:0>							
RxyPPS	_	—	_		F	RxyPPS<4:0>			242		
CLCxSELy	_				LCxDy	S<5:0>			412		

SUMMARY OF REGISTERS ASSOCIATED WITH EUSART TABLE 33-2:

Legend: — = unimplemented location, read as '0'. Shaded cells are not used for the EUSART module. *

Page with register information.

TABLE 37-11: RESET, WDT, OSCILLATOR START-UP TIMER, POWER-UP TIMER, BROWN-OUT RESET AND LOW-POWER BROWN-OUT RESET SPECIFICATIONS

Standard	Standard Operating Conditions (unless otherwise stated)									
Param. No.	Sym.	Characteristic	Min.	Тур†	Max.	Units	Conditions			
RST01*	TMCLR	MCLR Pulse Width Low to ensure Reset	2	_	_	μS				
RST02*	Tioz	I/O high-impedance from Reset detection			2	μS				
RST03	Twdt	Watchdog Timer Time-out Period		16	_	ms	16 ms Nominal Reset Time			
RST04*	TPWRT	Power-up Timer Period	_	65	_	ms				
RST05	Tost	Oscillator Start-up Timer Period ^(1,2)		1024	— /	∕~ T osc				
RST06	VBOR	Brown-out Reset Voltage ⁽⁴⁾	2.55 2.30 1.80	2.70 2.45 1.90	2.85 2.60 2.05		BORV = 0 BORV = 1 (F devices) BORV = 1 (LF devices)			
RST07	VBORHYS	Brown-out Reset Hysteresis		40 🧹	$\overline{)}$	m∖V ′				
RST08	TBORDC	Brown-out Reset Response Time	—	3	$\backslash - \backslash$	μs	\rangle			
RST09	VLPBOR	Low-Power Brown-out Reset Voltage	1.8	/ 1.9-	22	V V	LF Devices Only			

* These parameters are characterized but not tested.

† Data in "Typ" column is at 3.0V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

TABLE 37-12: ANALOG-TO-DIGITAL CONVERTER (ADC) ACCURACY SPECIFICATIONS^(1,2):

	Standard Operating Conditions (unless otherwise stated) VDD = 3.0V, TA = 25°C									
Param. No.	Sym.	Characteristic	Min.	Typt	Max.	Units	Conditions			
AD01	NR	Resolution	\sim	_	10	bit				
AD02	EIL	Integral Error	$\geq -$	±0.1	±1.0	LSb	ADCREF+ = 3.0V, ADCREF-= 0V			
AD03	Edl	Differential Error		±0.1	±1.0	LSb	ADCREF+ = 3.0V, ADCREF-= 0V			
AD04	EOFF	Offset Error	_	0.5	2.0	LSb	ADCREF+ = 3.0V, ADCREF-= 0V			
AD05	Egn	Gain Error 🗸 🖊 🔨	—	±0.2	±1.0	LSb	ADCREF+ = 3.0V, ADCREF-= 0V			
AD06	VADREF	ADC Reference Voltage (ADREF+ - ADREF-)	1.8		Vdd	V				
AD07	Vain	Fulf-Scale Range	ADREF-	_	ADREF+	V				
AD08	ZAIN	Recommended Impedance of Analog Voltage Source	_	10	—	kΩ				
AD09	RVREF	ADC Voltage Reference Ladder Impedance	—	50	—	kΩ	Note 3			

These parameters are characterized but not tested.

Data in "Typ" column is at 3.0V, 25°C unless otherwise stated. These parameters are for design guidance only and are not tested.

Note 1: Total Absolute Error is the sum of the offset, gain and integral non-linearity (INL) errors.

2: The ABC conversion result never decreases with an increase in the input and has no missing codes.

3: This is the impedance seen by the VREF pads when the external reference pads are selected.

<sup>Note 1: By design, the Oscillator Start-up Timer (OST) counts the first 1024 cycles, independent of frequency.
2: To ensure these voltage tolerances, VDD and Vss must be capacitively decoupled as close to the device as possible.</sup> 0.1 μF and 0.01 μF values in parallel are recommended.

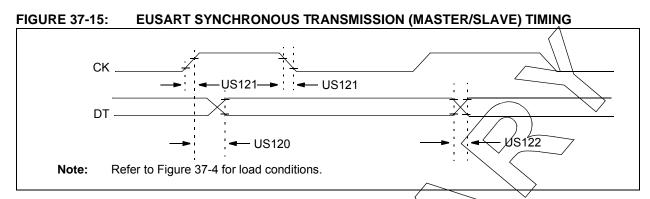


TABLE 37-21: EUSART SYNCHRONOUS TRANSMISSION CHARACTERISTICS

Param. No.	Symbol	Characteristic	Min.	Max.	Units	Conditions
JS120	TCKH2DTV	SYNC XMIT (Master and Slave)		80	ns	$3.0V \le V\text{DD} \le 5.5V$
Clock high to data-out valid	Clock high to data-out valid	$\langle - \rangle$	100	ns	$1.8V \leq V\text{DD} \leq 5.5V$	
US121	TCKRF	Clock out rise time and fall time	$\langle - \rangle$	45	ns	$3.0V \leq V\text{DD} \leq 5.5V$
		(Master mode)		✓ 50	ns	$1.8V \leq V\text{DD} \leq 5.5V$
US122	TDTRF	Data-out rise time and fall time	$\langle \rangle$	45	ns	$3.0V \leq V\text{DD} \leq 5.5V$
			$\overline{)}$	50	ns	$1.8V \le V\text{DD} \le 5.5V$

FIGURE 37-16: EUSART SYNCHRONOUS RECEIVE (MASTER/SLAVE) TIMING

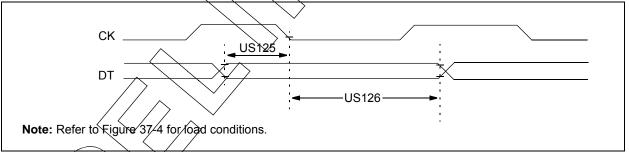
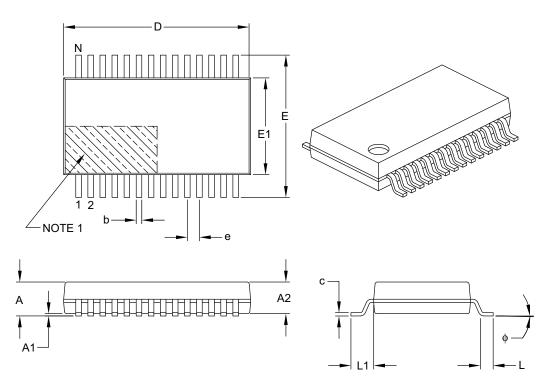


TABLE 37-22: EUSART SYNCHRONOUS RECEIVE REQUIREMENTS

Standard Operating C	Standard Operating Conditions (unless otherwise stated)									
Param. No. Symbol	> Characteristic	Min.	Max.	Units	Conditions					
	SYNC RCV (Master and Slave) Data-setup before CK \downarrow (DT hold time)	10	_	ns						
US126 TCKL2DTL	Data-hold after CK \downarrow (DT hold time)	15		ns						

28-Lead Plastic Shrink Small Outline (SS) – 5.30 mm Body [SSOP]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



	Units	MILLIMETERS			
	Dimension Limits	MIN	NOM	MAX	
Number of Pins	N		28		
Pitch	е		0.65 BSC		
Overall Height	А	_	-	2.00	
Molded Package Thickness	A2	1.65	1.75	1.85	
Standoff	A1	0.05	-	-	
Overall Width	E	7.40	7.80	8.20	
Molded Package Width	E1	5.00	5.30	5.60	
Overall Length	D	9.90	10.20	10.50	
Foot Length	L	0.55	0.75	0.95	
Footprint	L1	1.25 REF			
Lead Thickness	С	0.09	-	0.25	
Foot Angle	φ	0°	4°	8°	
Lead Width	b	0.22	-	0.38	

Notes:

1. Pin 1 visual index feature may vary, but must be located within the hatched area.

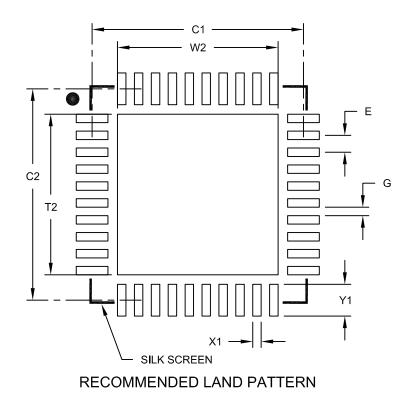
Dimensions D and E1 do not include mold flash or protrusions. Mold flash or protrusions shall not exceed 0.20 mm per side.
 Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances. REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-073B

40-Lead Plastic Ultra Thin Quad Flat, No Lead Package (MV) - 5x5 mm Body [UQFN]

Note: For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging



		ILLIMETER		
	Units			
Dimensio	Dimension Limits			MAX
Contact Pitch	E	0.40 BSC		
Optional Center Pad Width	W2			3.80
Optional Center Pad Length	T2			3.80
Contact Pad Spacing	C1	5.00		
Contact Pad Spacing	C2		5.00	
Contact Pad Width (X40)	X1			0.20
Contact Pad Length (X40)	Y1	0.75		
Distance Between Pads	G	0.20		

Notes:

1. Dimensioning and tolerancing per ASME Y14.5M

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

Microchip Technology Drawing No. C04-2156B